









# B1M160120HC

#### 1200V A 160mΩ A 20A A SIC MOSFET

SILICON CARBIDE SiC MOSFET ▲ THT type

N-channel enhancement mode

Low on-resistance and capacitance

TO-247-3L package ▲ Epoxy meets UL94-V0

Avalanche ruggedness

Especially for higher system efficiency

Item (T <sub>c</sub> = 25°C, unless otherwise noted)		Characteristics
Operating Temperature Range	Tj	-55°C to +150°C
Storage Temperature Range	Ts	-55°C to +150°C
Drain-Source Voltage	V <sub>DS MAX</sub>	1200V
Continuous Drain Current	l <sub>D</sub>	20A
Drain-Source On-State Resistance Note 1	R <sub>DS(ON)TYP</sub>	160mΩ
Reverse Transfer Capacitance Note 2	C <sub>RSS</sub>	18pF
Power Dissipation	P <sub>D</sub>	118W

#### **Notes**

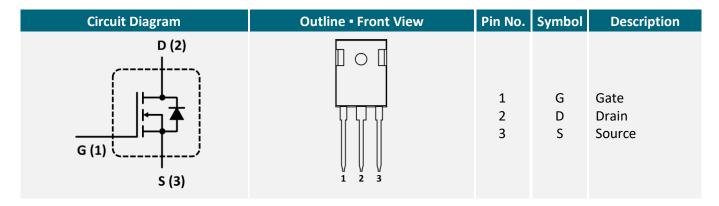
1:  $V_{GS} = 20V, I_D = 10A$ 

2:  $V_{DS} = 800V$ ,  $V_{GS} = 0V$ , f = 1MHz,  $V_{AC} = 25mV$ 

#### **APPLICATIONS**

EV Charging	Industrial Inverters	Motors & Drives	Power Factor Correction	Renewable Energy	SMPS	UPS
<b>₹</b> ¶ <b>#</b>			PFC	*		

#### **PIN DESCRIPTION**





## ABSOLUT MAXIMUM RATINGS ▲ T<sub>C</sub> = 25°C, unless otherwise noted

ltem	Condition	Symbol		Unit
Drain-Source Breakdown Voltage	$V_{GS} = 0V$ , $I_{DS} = 100\mu A$	$V_{DSMAX}$	1200	V
Continuous Drain Current	$V_{GS} = 20V, T_C = 25^{\circ}C$	$I_D$	20	Α
Continuous Drain Current	$V_{GS} = 20V, T_C = 100^{\circ}C$	$I_D$	13	Α
Pulse Drain Current	Pulse with $t_p$ limited by $T_{JMAX}$	I <sub>D, pulse</sub>	40	Α
Power Dissipation	T <sub>C</sub> = 25°C	$P_{D}$	118	W
Gate Source Voltage		V <sub>GS, MAX</sub>	-10/+25	V
Recommended Gate Source Voltage		$V_{GS, op}$	-5/+20	V
Operating Junction Temperature		TJ	-55 to +150	°C
Operating Junction Temperature		TJ	-55 to +150	°C

# **ELECTRICAL CHARACTERISTICS** ▲ T<sub>J</sub> = 25°C, unless otherwise noted

Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$V_{GS} = 0V$ , $I_D = 100 \mu A$	$V_{(BR)DSS}$	1200			V
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5 \text{mA}$	$V_{GS(th)}$		2.7		V
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5 \text{mA}$ , $T_J = 150 ^{\circ} \text{C}$	$V_{GS(th)}$		2.1		V
Zero Gate Voltage Drain Current	$V_{DS} = 1200V, V_{GS} = 0V$	I <sub>DSS</sub>		0.7	45	μΑ
Zero Gate Voltage Drain Current	$V_{DS} = 1200V$ , $V_{GS} = 0V$ , $T_J = 150$ °C	$I_{DSS}$		5	200	μΑ
Gate-Source Leakage Current	$V_{GS} = 20V$ , $V_{DS} = 0V$	I <sub>GSS</sub>			250	nA
Drain-Source On-State Resistance	$V_{GS} = 20V, I_D = 10A$	R <sub>DS(ON)</sub>		160		mΩ
Drain-Source On-State Resistance	$V_{GS} = 20V$ , $I_D = 10A$ , $T_J = 150$ °C	R <sub>DS(ON)</sub>		244		mΩ
Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Dynamic Characteristics						
Input Capacitance	$V_{DS}$ = 800V, $V_{GS}$ = 0V, f = 1MHz, $V_{AC}$ = 25mV	C <sub>ISS</sub>		1100		pF
Output Capacitance	$V_{DS}$ = 800V, $V_{GS}$ = 0V, f = 1MHz, $V_{AC}$ = 25mV	Coss		73		pF
Reverse Transfer Capacitance	$V_{DS}$ = 800V, $V_{GS}$ = 0V, f = 1MHz, $V_{AC}$ = 25mV	$C_{RSS}$		18		pF
Internal Gate Resistance	$f = 1MHz$ , $V_{AC} = 25mV$	R <sub>G(INT.)</sub>		2.8		Ω
Turn-On Delay Time	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	t <sub>D(ON)</sub>		15		ns
Rise Time	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	$t_R$		19		ns
Turn-Off Delay Time	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	t <sub>D(OFF)</sub>		20		ns
Fall Time	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	t <sub>F</sub>		22		ns
Turn-on Switching Energy	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	E <sub>ON</sub>		63		μЈ
Turn-off Switching Energy	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A, $R_{G(ext)}$ = 2.2 $\Omega$ , Inductive Load	E <sub>OFF</sub>		72		μЈ



## BUILT-IN SiC DIODE CHARACTERISTICS A T<sub>J</sub> = 25°C, unless otherwise noted

Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Source-Drain Diode						
Inverse Diode Forward Voltage	$V_{GS} = -5V$ , $I_{SD} = 5A$	$V_{\text{SD}}$		5.1		V
Reverse Recovery Charge	$V_{GS} = 5V$ , $I_{SD} = 10A$ , $V_{DS} = 800V$ , di/dt = 400A/ $\mu$ s	$Q_{RR}$		82		nC
Peak Reverse Recovery Current	$V_{GS} = 5V$ , $I_{SD} = 10A$ , $V_{DS} = 800V$ , $di/dt = 400A/\mu s$	I <sub>RRM</sub>		2.45		Α

## GATE CHARGE CHARACTERISTICS ▲ T<sub>J</sub> = 25°C, unless otherwise noted

ltem	Condition	Symbol	Min.	Тур.	Max.	Unit
Gate to Source Charge	$V_{DS} = 800V$ , $V_{GS} = -5/+20V$ , $I_D = 10A$	$Q_{GS}$		12		nC
Gate to Drain Charge	$V_{DS} = 800V$ , $V_{GS} = -5/+20V$ , $I_D = 10A$	$Q_{GD}$		31		nC
Total Gate Charge	$V_{DS}$ = 800V, $V_{GS}$ = -5/+20V, $I_{D}$ = 10A	$Q_{G}$		60		nC

#### THERMAL RESISTANCE PERFORMANCE

Item	Symbol	Min.	Тур.	Max.	Unit
Thermal Resistance, Junction to Case			1.085		K/W



#### REFERENCE DATA A TYPICAL DEVICE PERFORMANCE

Fig. 1 • Forward Output Characteristics I<sub>DS</sub> vs. V<sub>DS</sub>, T<sub>J</sub> = 25°C

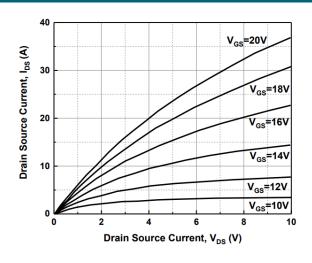


Fig. 2 • Forward Output Characteristics  $I_{DS}$  vs.  $V_{DS}$ ,  $T_C = 150$ °C

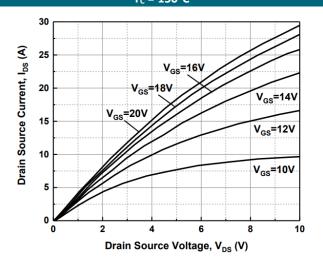


Fig. 3 • Transfer Characteristics for various Junction Temperature T<sub>J</sub>

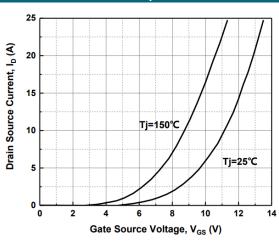


Fig. 4 • On-Resistance R<sub>ON</sub> vs. Gate Voltage V<sub>GS</sub> for various Junction Temperature T<sub>J</sub>

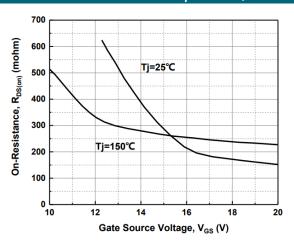


Fig. 5 • On-Resistance  $R_{ON}$  vs. Junction Temperature  $T_J$  at  $V_{GS}$  = 20V,  $I_{DS}$  = 10A

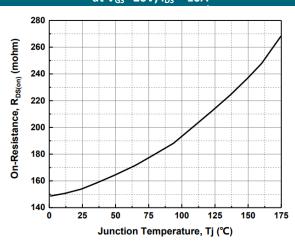
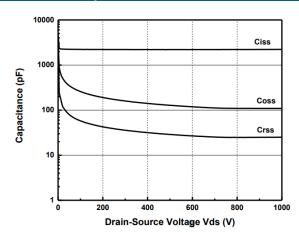


Fig. 6 • Capacitances vs. Drain to Source Voltage V<sub>DS</sub> (0 to 1000V)





#### REFERENCE DATA A TYPICAL DEVICE PERFORMANCE

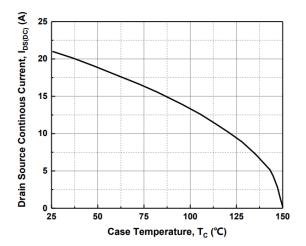


Fig. 8 • Maximum Power Dissipation Derating  $P_D$  vs. Case Temperature  $T_C$ 

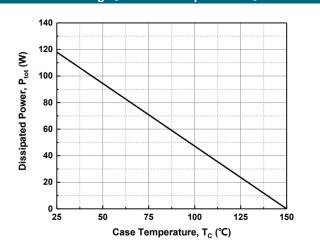


Fig. 9 • Transient Thermal Impedance
(Junction – Case)

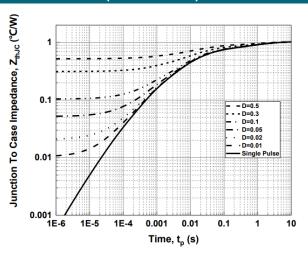
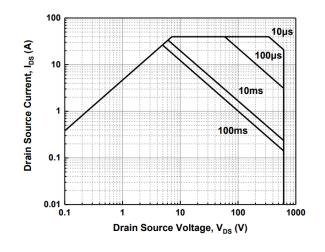
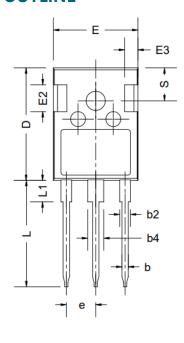


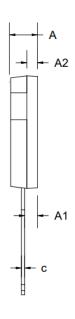
Fig. 10 • Safe Operating Area

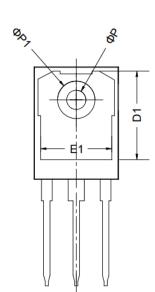




## **PACKAGE OUTLINE**









Sym	Millimeters (Min.)	Millimeters (Typ.)	Millimeters (Max.)
Α	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
С	0.51	0.61	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10

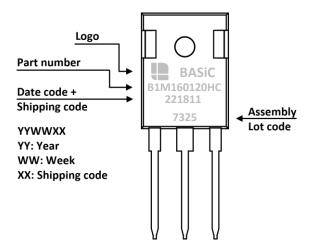
Sym	Millimeters (Min.)	Millimeters (Typ.)	Millimeters (Max.)		
E1	13.00	13.30	13.60		
E2	4.80	5.00	5.20		
E3	2.30	2.50	2.70		
e	5.44 BSC				
L	19.62	19.92	20.22		
L1	-	-	4.30		
ØΡ	3.40	3.60	3.80		
ØP1	-	-	7.30		
S	6.16 BSC				

### **ORDERING INFORMATION**

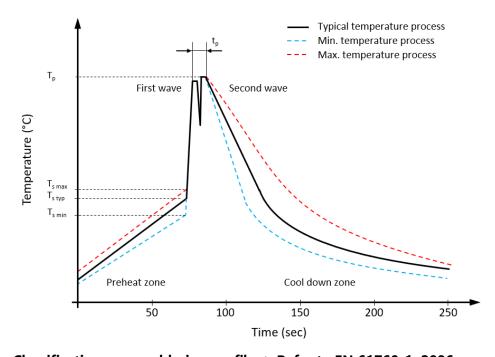
Pa	rt Number	Package	Packing	Tube Qty.	Inner Box Qty.	Outer Box Qty.
B1N	И160120HC	TO-247-3L	Tube	30pcs	300pcs	1.800pcs



#### **PART MARKING**



### RECOMMENDED WAVE SOLDERING PROFILE A THT PACKAGE



### Classification wave soldering profile ▲ Refer to EN 61760-1: 2006

Profile Features		Value <u>▲</u> Sn-Pb Assembly	Value <u>▲</u> Pb-free Assembly
Preheat temperature min.	$T_{smin}$	100 °C	100 °C
Preheat temperature typical	T <sub>s typ</sub>	120 °C	120 °C
Preheat temperature max.	$T_{s max}$	130 °C	130 °C
Preheat time $t_s$ from $T_{smin}$ to $T_{smax}$	ts	70 seconds	70 seconds
Peak temperature	Tp	235 °C to 260 °C	245 °C to 260 °C
Time of actual peak temperature	tp	Max. 10 seconds Max. 5 second each wave	Max. 10 seconds Max. 5 second each wave
Ramp-down date min.		~ 2 °C/second	~ 2 °C/second
Ramp-down rate typical		~ 3.5 °C/second	~ 3.5 °C/second
Ramp-down rate max.		~ 5 °C/second	~ 5 °C/second

MGT ▲ Manufacturer Group of Technology



#### **REVISION TABLE**

Revision	Date	Status	Notes
001	30/09/2022	Initial release	Initial publication

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